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## Front Matter: Volume 9820

, "Front Matter: Volume 9820," Proc. SPIE 9820, Infrared Imaging Systems: Design, Analysis, Modeling, and Testing XXVII, 982001 (2 July 2016); doi: 10.1117/12.2244359

**SPIE.**

Event: SPIE Defense + Security, 2016, Baltimore, Maryland, United States

# PROCEEDINGS OF SPIE

## ***Infrared Imaging Systems: Design, Analysis, Modeling, and Testing XXVII***

**Gerald C. Holst  
Keith A. Krapels**  
*Editors*

**19–21 April 2016  
Baltimore, Maryland, United States**

*Sponsored and Published by*  
SPIE

**Volume 9820**

Proceedings of SPIE 0277-786X, V. 9820

SPIE is an international society advancing an interdisciplinary approach to the science and application of light.

**Infrared Imaging Systems: Design, Analysis, Modeling, and Testing XXVII,**  
edited by Gerald C. Holst, Keith A. Krapels, Proc. of SPIE Vol. 9820, 982001  
2016 SPIE · CCC code: 0277-786X/16/\$18 · doi: 10.1117/12.2244359

Proc. of SPIE Vol. 9820 982001-1

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Author(s), "Title of Paper," in *Infrared Imaging Systems: Design, Analysis, Modeling, and Testing XXVII*, edited by Gerald C. Holst, Keith A. Krapels, Proceedings of SPIE Vol. 9820 (SPIE, Bellingham, WA, 2016) Six-digit Article CID Number.

ISSN: 0277-786X  
ISSN: 1996-756X (electronic)  
ISBN: 9781510600614

Published by

**SPIE**

P.O. Box 10, Bellingham, Washington 98227-0010 USA  
Telephone +1 360 676 3290 (Pacific Time) · Fax +1 360 647 1445  
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